

LSSF65R600S2/LSSP65R600S2/LSSB65R600S2 650V N-Channel Super-Junction MOSFET Gen- II

Description

SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance.

This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy.

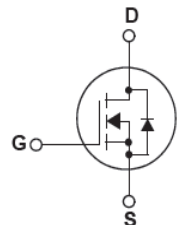
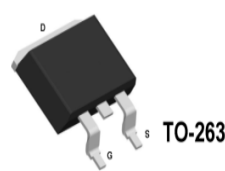
SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.

Features

- Multi-Epi process SJ-FET
- 700V @T_J = 150 °C
- Typ. R_{DS(on)} = 0.54Ω
- Ultra Low Gate Charge (typ. Q_g = 11.8nC)
- 100% avalanche tested

LSSF65R600S2

LSSP65R600S2

LSSB65R600S2


Symbol	Parameter	LSSP_B65R600S2		LSSF65R600S2	Unit
V _{DSS}	Drain-Source Voltage	650			V
I _D	Drain Current -Continuous (TC = 25°C) -Continuous (TC = 100°C)	8* 5*			A
I _{DM}	Drain Current - Pulsed (Note 1)	32			A
V _{GSS}	Gate-Source voltage	±30			V
E _{AS}	Single Pulsed Avalanche Energy (Note 2)	240			mJ
I _{AS}	Avalanche current, repetitive or not-repetitive (pulse width limited by T _J max)	4			A
dv/dt	Peak Diode Recovery dv/dt (Note 3)	15			V/ns
dVds/dt	Drain Source voltage slope (Vds=480V)	50			V/ns
P _D	Power Dissipation (TC = 25°C)	80		30	W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150			°C
T _L	Maximum Lead Temperature for Soldering Purpose, 1/16" from Case for 10 Seconds	260			°C

* Drain current limited by maximum junction temperature. Maximum duty cycle D=0.75.

Thermal Characteristics

Symbol	Parameter	LSSP_B65R600S2	LSSF65R600S2	Unit
R _{θJC}	Thermal Resistance, Junction-to-Case	1.55	4.2	°C/W
R _{θCS}	Thermal Resistance, Case-to-Sink Typ.	0.5	-	°C/W
R _{θJA}	Thermal Resistance, Junction-to-Ambient	62	80	°C/W

Electrical Characteristics TC = 25°C unless otherwise noted

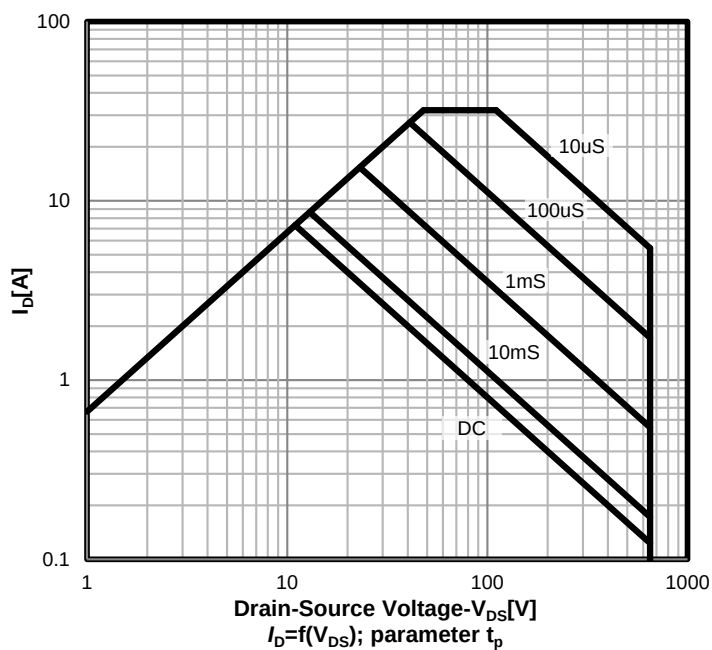
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0V, I _D = 250μA, T _J = 25°C	650	-	-	V
		V _{GS} = 0V, I _D = 250μA, T _J = 150°C	700	-	-	V
ΔBV _{DSS} /ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250μA, Referenced to 25°C	-	0.6	-	V/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 650V, V _{GS} = 0V -T _J = 125°C	-	-	1 100	μA μA
I _{GSSF}	Gate-Body Leakage Current, Forward	V _{GS} = 30V, V _{DS} = 0V	-	-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	V _{GS} = -30V, V _{DS} = 0V	-	-	-100	nA
On Characteristics						
V _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	2.0	3.0	4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} = 10V, I _D = 4A	-	0.54	0.6	Ω
Dynamic Characteristics						
C _{iss}	Input Capacitance	V _{DS} = 50V, V _{GS} = 0V, f = 1.0MHz	-	480	-	pF
C _{oss}	Output Capacitance		-	36	-	pF
C _{rss}	Reverse Transfer Capacitance		-	2.3	-	pF
Q _g	Total Gate Charge	V _{DS} = 400V, I _D = 4A, V _{GS} = 10V (Note 4)	-	11.8	-	nC
Q _{gs}	Gate-Source Charge		-	2.4	-	nC
Q _{gd}	Gate-Drain Charge		-	4.7	-	nC
V _{plateau}	Gate plateau voltage		-	4.8	-	V
R _g	Gate resistance	f=1 MHz, open drain	-	10	-	Ω
Switching Characteristics						
t _{d(on)}	Turn-On Delay Time	V _{DS} = 400V, I _D = 8A R _G = 25Ω, V _{GS} = 10V (Note 4)	-	17	-	ns
t _r	Turn-On Rise Time		-	26	-	ns
t _{d(off)}	Turn-Off Delay Time		-	53	-	ns
t _f	Turn-Off Fall Time		-	38	-	ns
Drain-Source Diode Characteristics and Maximum Ratings						
I _S	Maximum Continuous Drain-Source Diode Forward Current		-	-	8	A
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current		-	-	32	A
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0V, I _S = 8A	-	0.9	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0V, V _{DS} = 400V, I _S = 4A, dI _F /dt =100A/μs	-	240	-	ns
Q _{rr}	Reverse Recovery Charge		-	1.5	-	μC
I _{rrm}	Peak Reverse Recovery Current		-	13.5	-	A

NOTES:

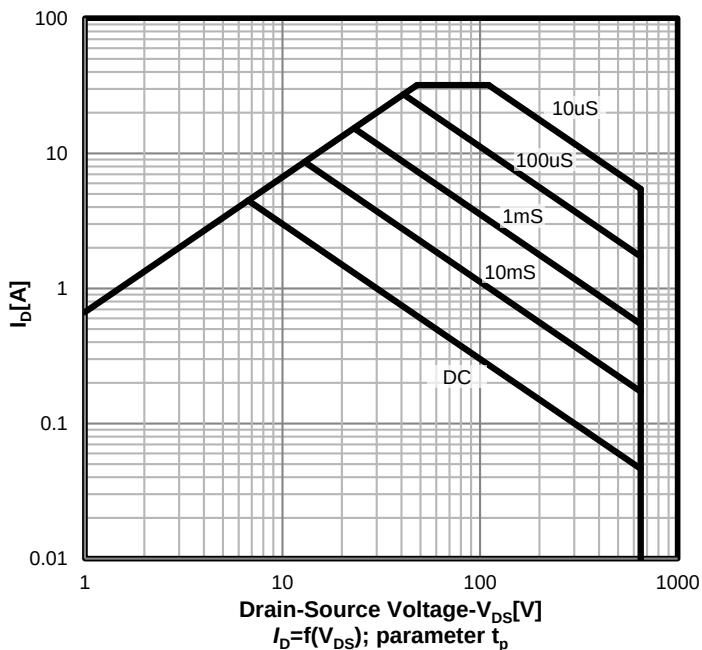
1. Repetitive Rating: Pulse width limited by maximum junction temperature
2. I_D=I_{AS}, V_{DD}=50V, L=30mH, Starting T_J=25 °C
3. I_{SD}≤I_D, di/dt ≤ 200A/μs, V_{DD} ≤ BV_{DSS}, Starting T_J = 25 °C
4. Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

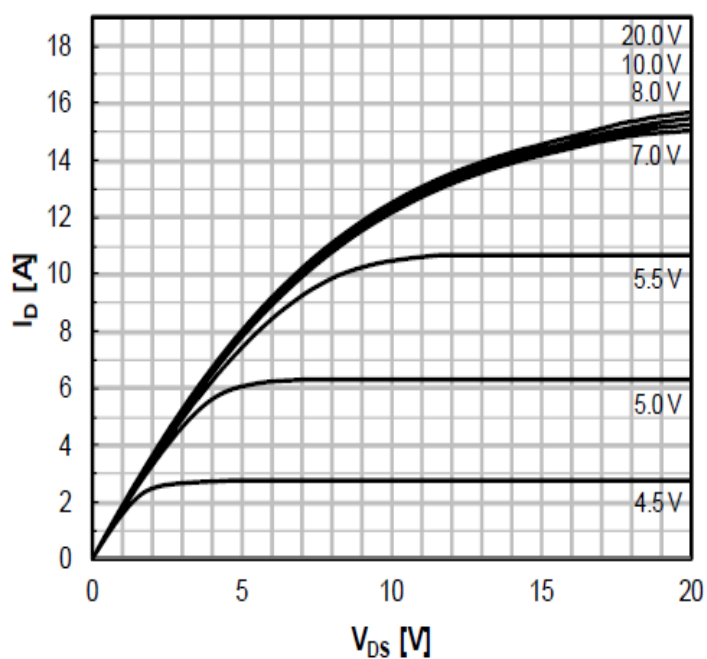
Safe operating area TC=25 °C
TO-220,TO-263



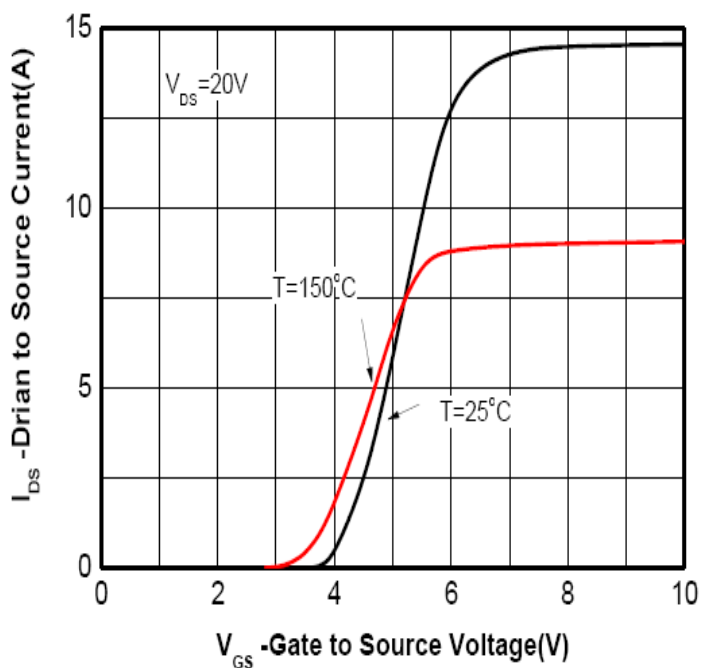
Safe operating area TC=25 °C
TO-220FullPAK



Typ. output characteristics $T_J=25\text{ }^{\circ}\text{C}$

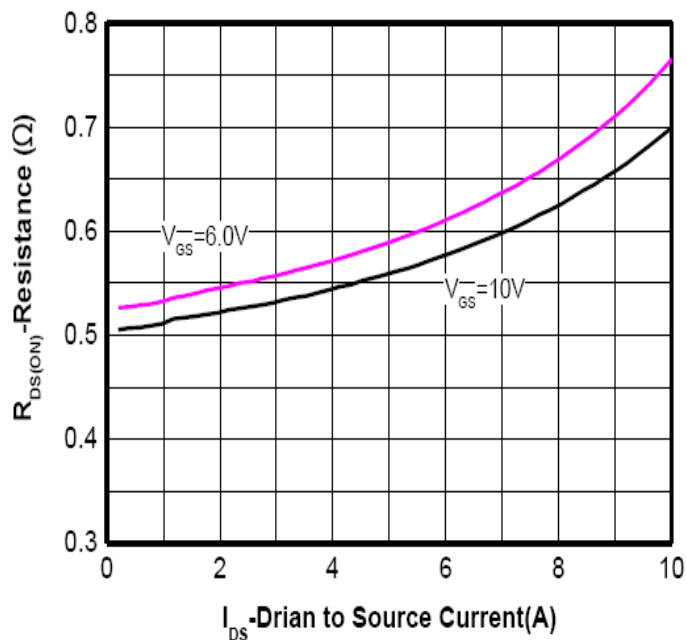


Typ. transfer characteristics

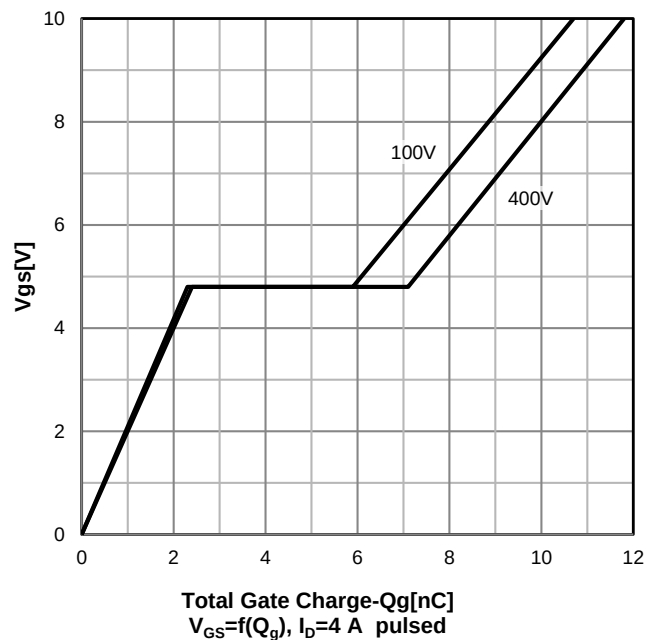


Typical Performance Characteristics

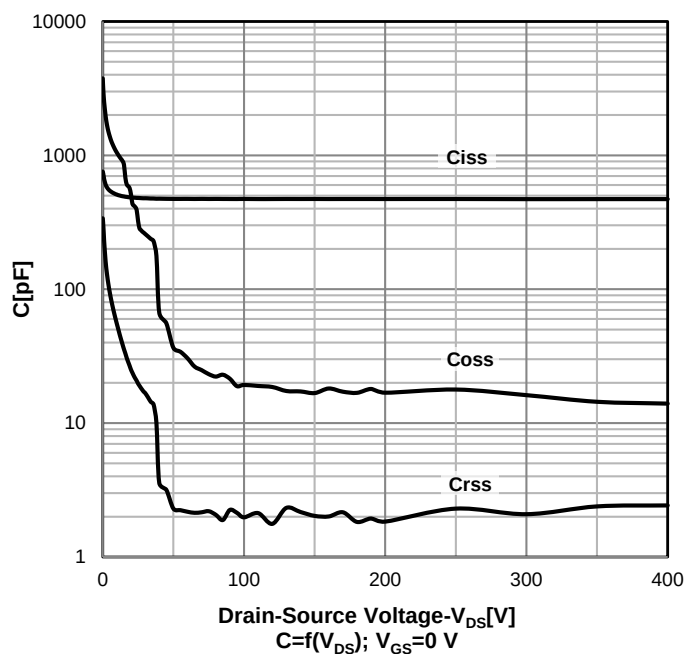
Typ. drain-source on-state resistance



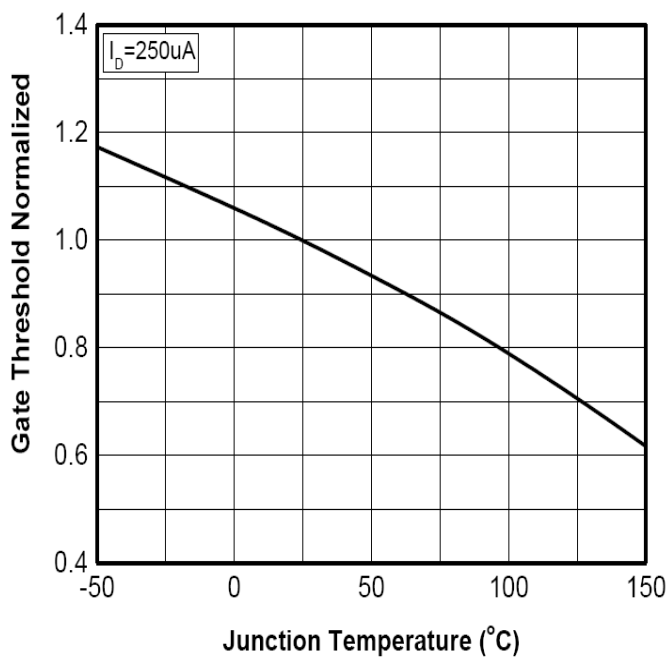
Typ. gate charge characteristics



Typ. capacitances

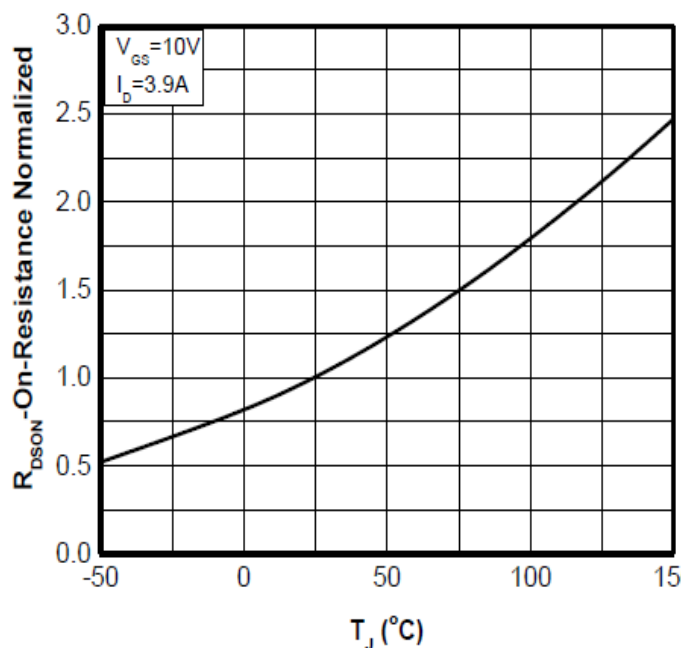


Normalized $V_{GS(th)}$ characteristics

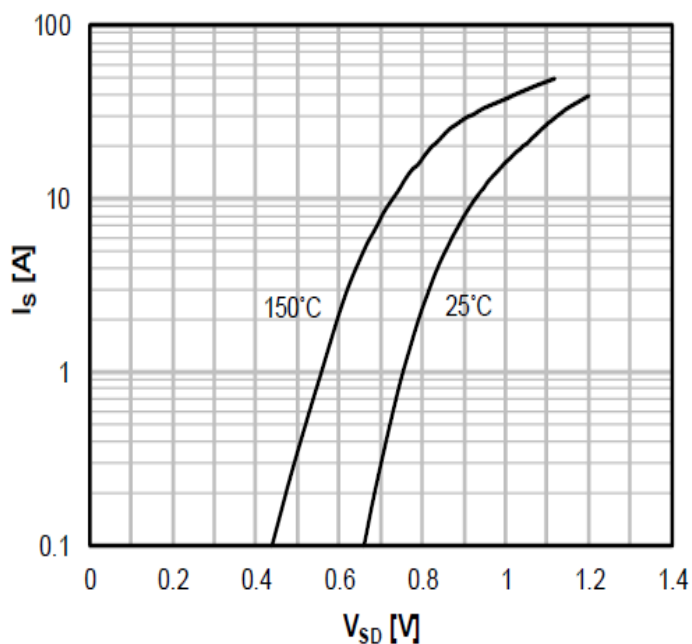


Typical Performance Characteristics

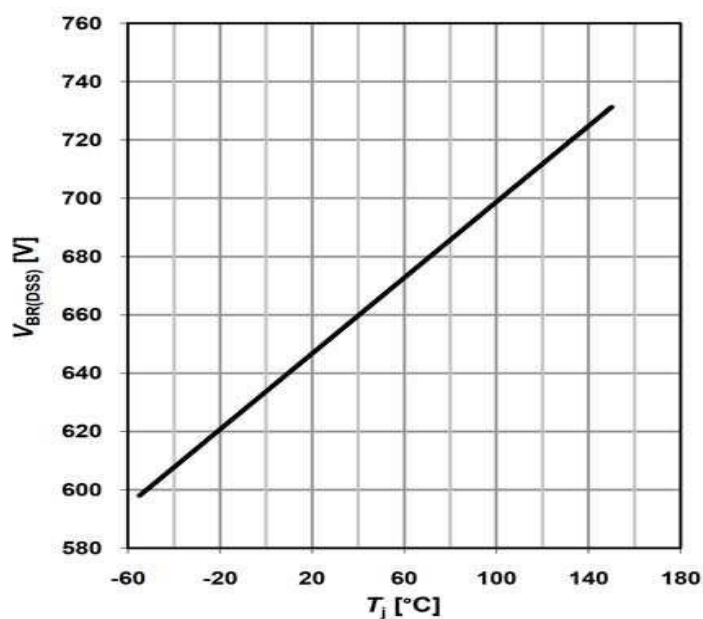
Normalized on-resistance vs temperature



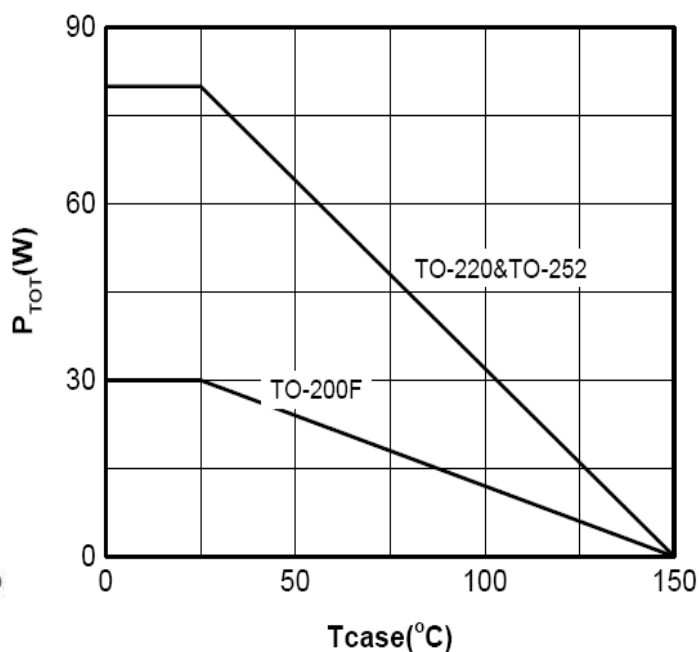
Forward characteristics of reverse diode



Drain-source breakdown voltage

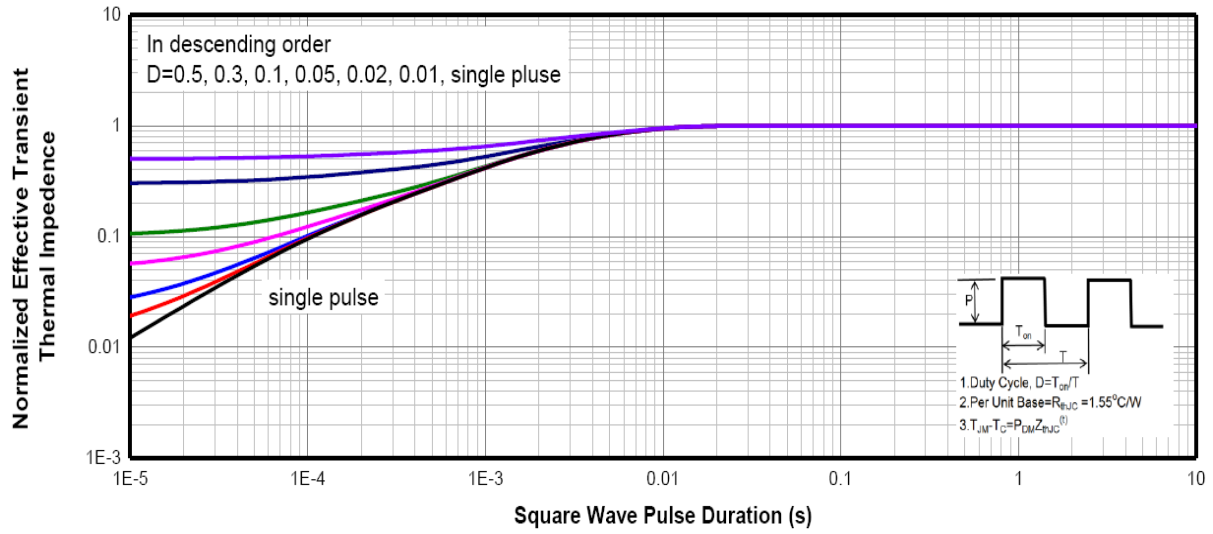


Power dissipation

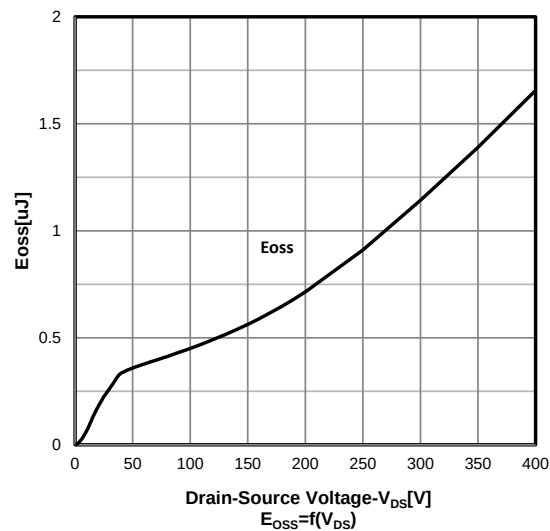
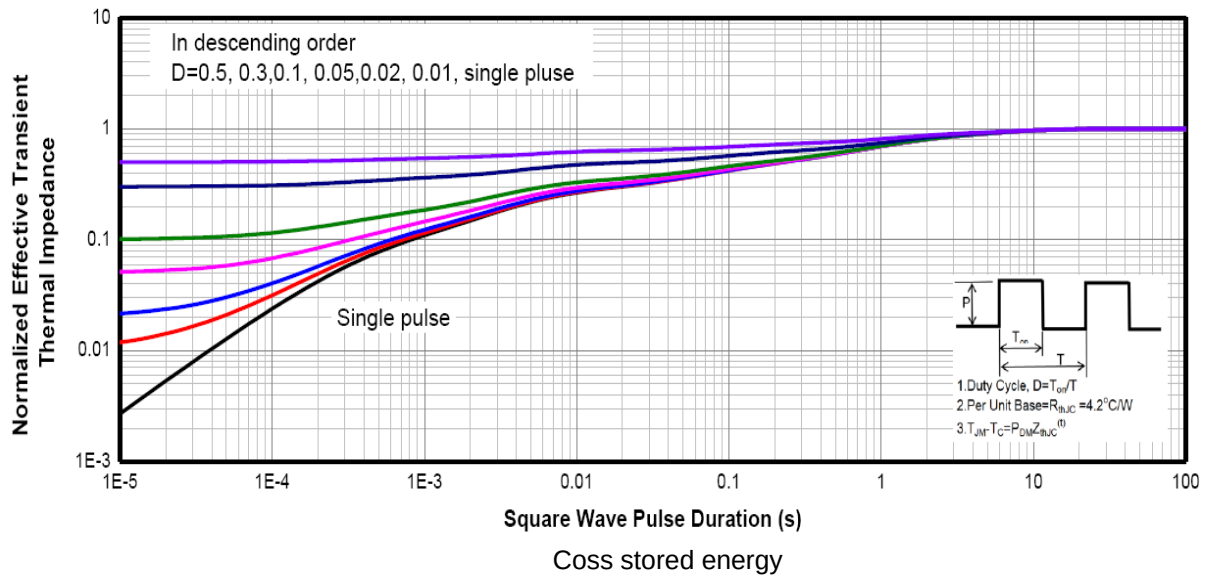


Typical Performance Characteristics

Max. transient thermal impedance
TO-220,TO-263

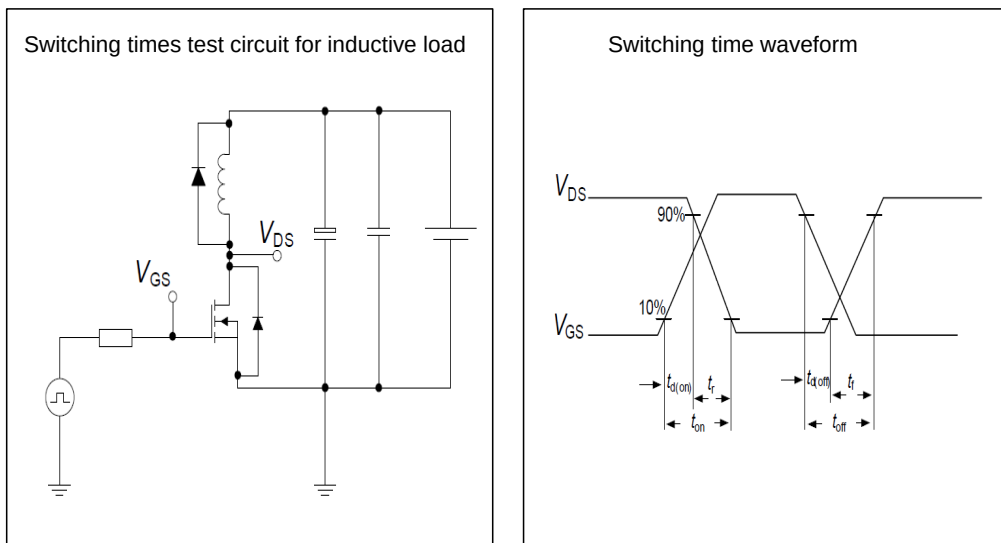


Max. transient thermal impedance
TO-220FullPAK

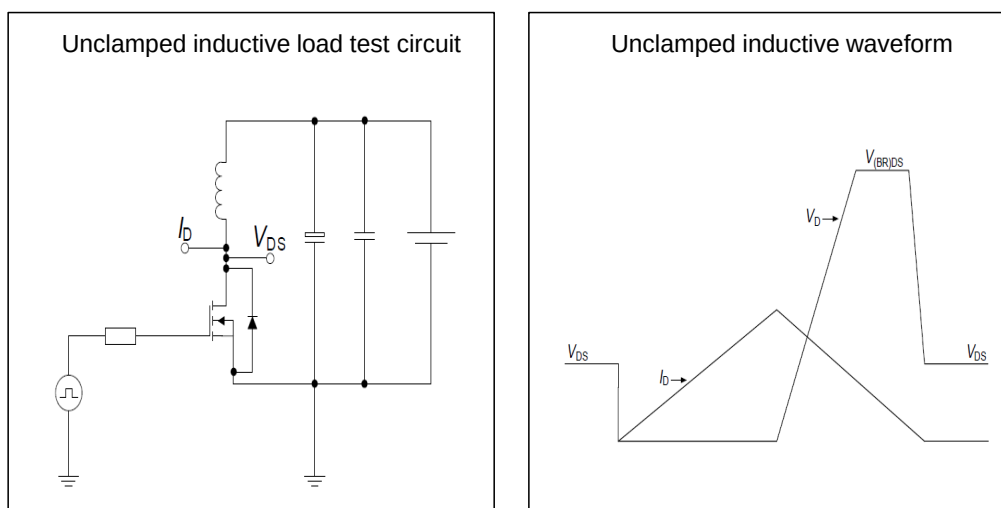


Test circuits

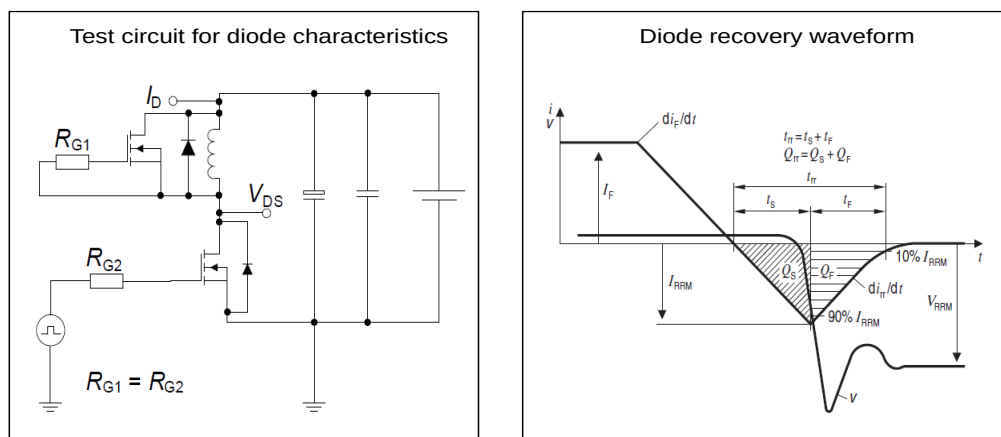
Switching times test circuit and waveform for inductive load



Unclamped inductive load test circuit and waveform

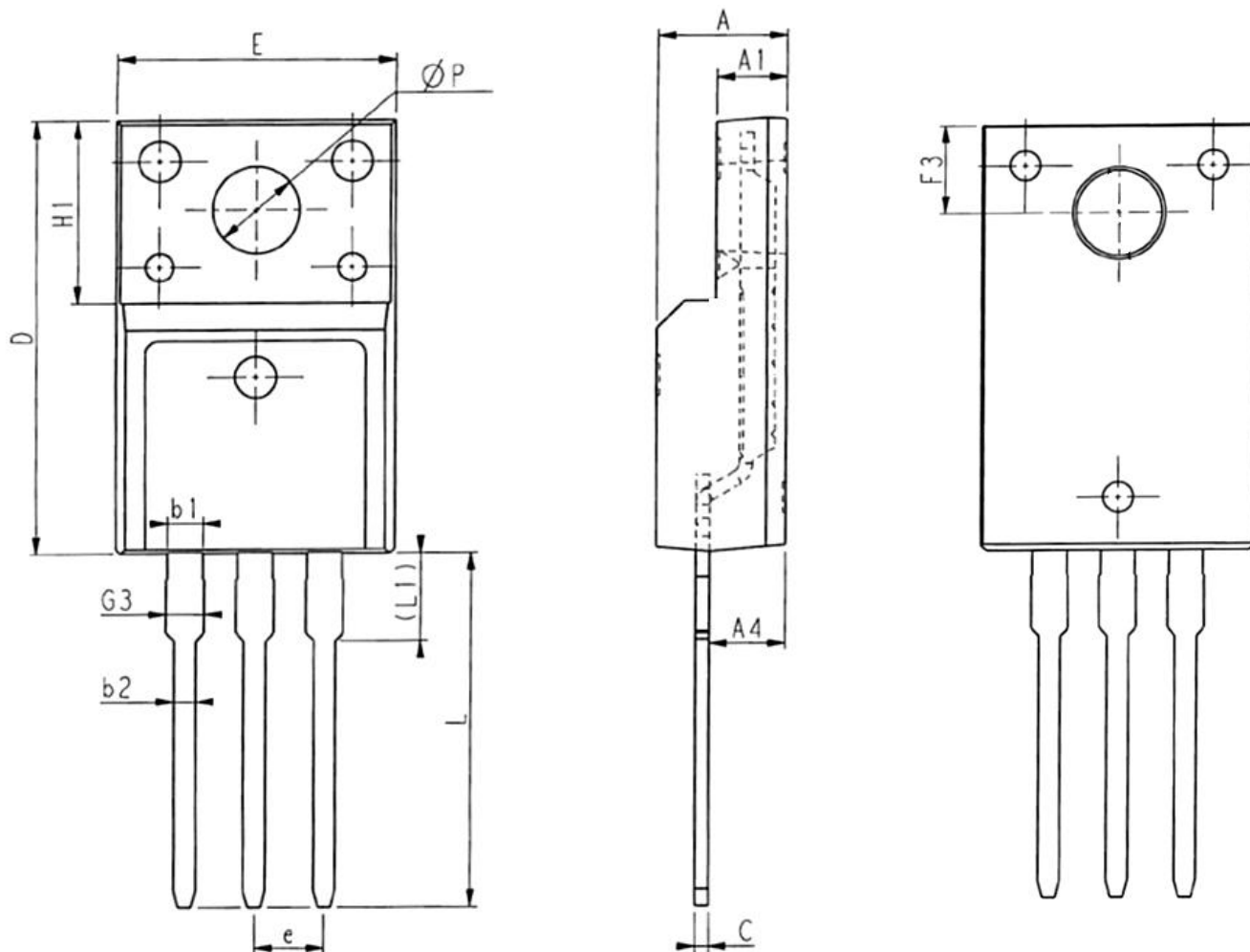


Test circuit and waveform for diode characteristics



Package Outline

TO-220 Full PAK

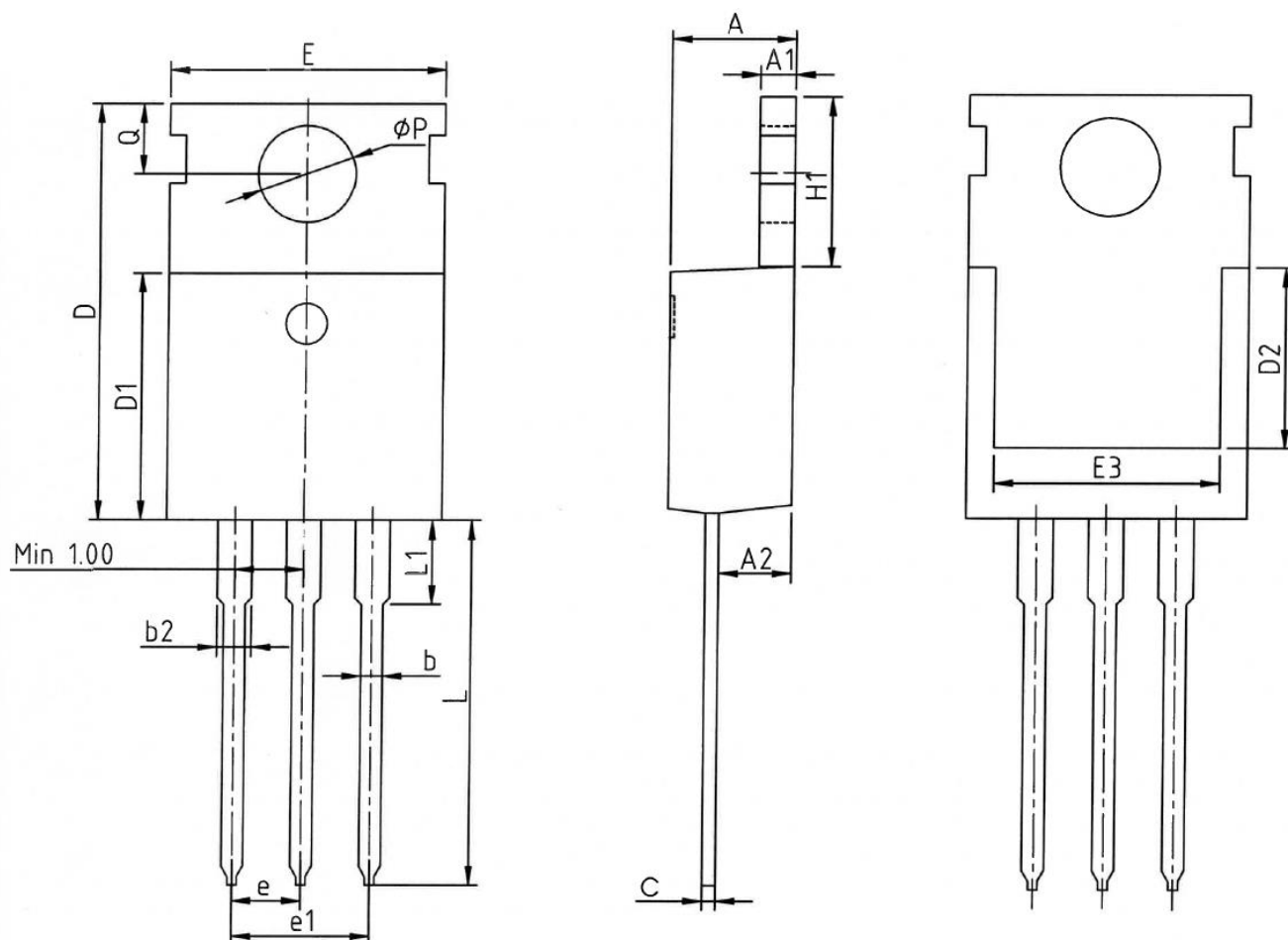


COMMON DIMENSIONS

SYMBOL	UNIT(mm)		
	MIN	NOM	MAX
E	9.86	10.16	10.36
A	4.50	4.70	4.90
A1	2.34	2.54	2.84
A4	2.56	2.76	2.96
C	0.35	0.50	0.65
D	15.50	15.87	16.25
H1	6.70REF		
e	2.54BSC		
L	12.60	12.98	13.35
L1	3.03	3.23	3.43
ΦP	3.00	3.20	3.40
F3	3.10	3.30	3.50
G3	1.20	1.35	1.60
b1	1.18	1.28	1.43
b2	0.70	0.80	0.95

Package Outline

TO-220

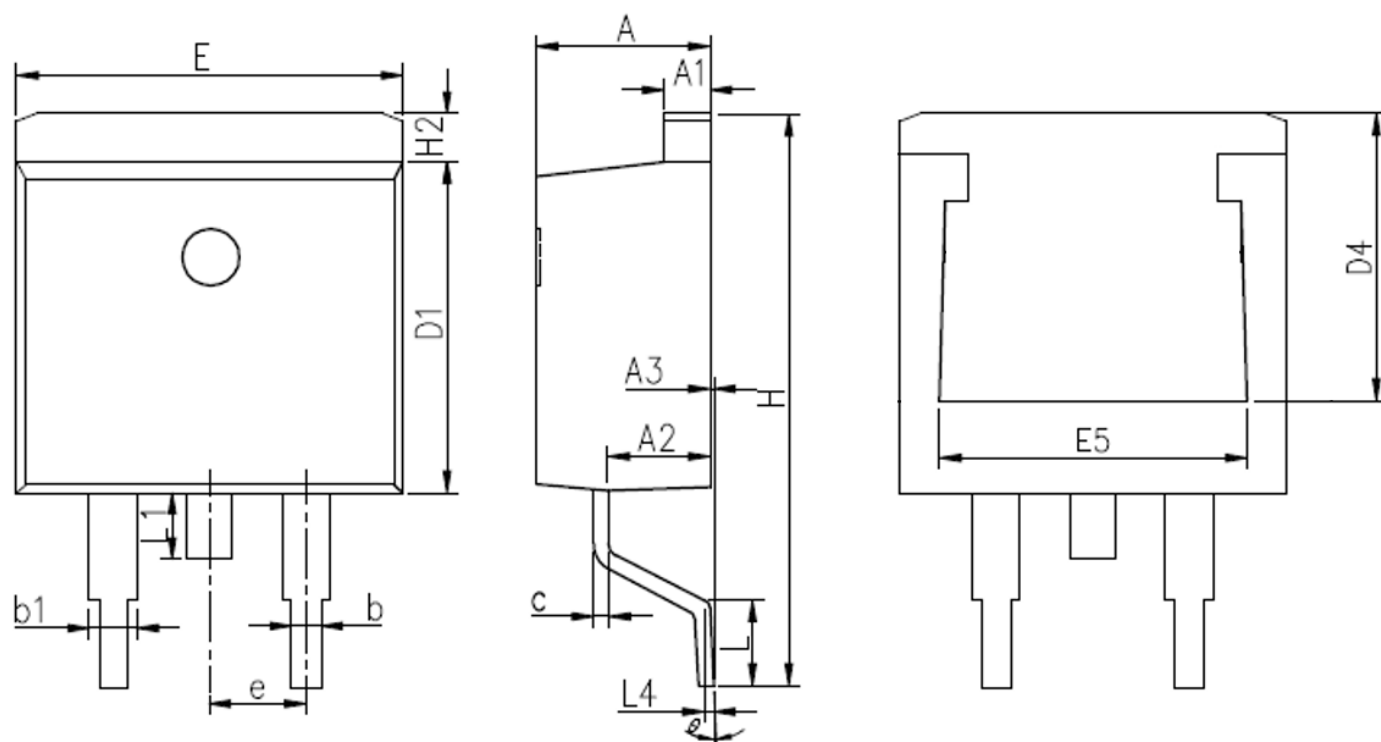


COMMON DIMENIONS

SYMBOL	MIN	NOM	MAX
A	4.37	4.57	4.70
A1	1.25	1.30	1.40
A2	2.20	2.40	2.60
b	0.70	0.80	0.95
b2	1.17	1.27	1.47
c	0.45	0.50	0.60
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	6.30	7.10
E	9.70	10.00	10.30
E3	7.00	7.80	8.60
e	2.54 BSC		
e1	5.08 BSC		
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ΦP	3.40	3.60	3.80
Q	2.60	2.80	3.00

Package Outline

TO-263



COMMON DIMENSIONS

SYMBOL	MM		
	MIN	NOM	MAX
A	4.37	4.57	4.77
A1	1.22	1.27	1.42
A2	2.49	2.69	2.89
A3	0.00	0.13	0.25
b	0.70	0.81	0.96
b1	1.17	1.27	1.47
c	0.30	0.38	0.53
D1	8.50	8.70	8.90
D4	6.60	-	-
E	9.86	10.16	10.36
E5	7.06	-	-
e	2.54 BSC		
H	14.70	15.10	15.50
H2	1.07	1.27	1.47
L	2.00	2.30	2.60
L1	1.40	1.55	1.70
L4	0.25 BSC		
θ	0°	5°	9°

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